

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

MIYASHITA, TOMOYUKI

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
382	100, 232	4/29/2005	SN
380	51, 202	4/29/2005	SN
380	203, 204	4/29/2005	SN
380	216	4/29/2005	SN
713	176, 179	4/29/2005	SN
348	460	4/29/2005	SN
358	3.28	4/29/2005	SN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
382	100	4/30/2005	SN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Classification text Search (Attached)	4/29/2005	SN
Text Search EAST (Attached)	4/29/2005	SN
Text Search EAST (Attached)	4/30/2005	SN
IEEE Database Search (Attached)	4/30/2005	SN